

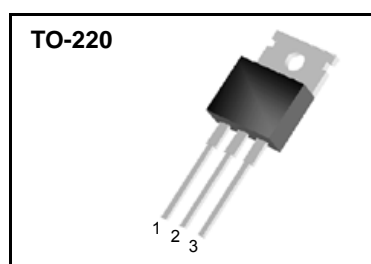
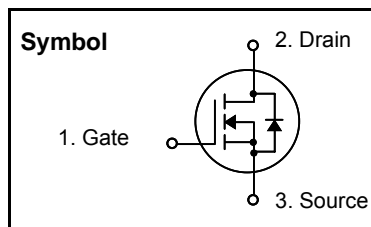
## Logic N-Channel MOSFET

### Features

- Low  $R_{DS(on)}$  ( $0.0135\Omega$ )@ $V_{GS}=10V$
- Low Gate Charge (Typical 21.5nC)
- Low  $C_{rss}$  (Typical 130pF)
- Improved dv/dt Capability
- 100% Avalanche Tested
- Maximum Junction Temperature Range (175°C)

### General Description

This Power MOSFET is produced using SemiWell's advanced planar stripe, DMOS technology. This latest technology has been especially designed to minimize on-state resistance, have a low gate charge with superior switching performance, and rugged avalanche characteristics. This Power MOSFET is well suited for synchronous DC-DC Converters and Power Management in portable and battery operated products.



### Absolute Maximum Ratings

| Symbol         | Parameter  | Value      | Units |
|----------------|--|------------|-------|
| $V_{DSS}$      | Drain to Source Voltage  | 30         | V     |
| $I_D$          | Continuous Drain Current(@ $T_C = 25^\circ C$ )                              | 60         | A     |
|                | Continuous Drain Current(@ $T_C = 100^\circ C$ )                             | 43         | A     |
| $I_{DM}$       | Drain Current Pulsed (Note 1)  | 240        | A     |
| $V_{GS}$       | Gate to Source Voltage   | $\pm 20$   | V     |
| $E_{AS}$       | Single Pulsed Avalanche Energy (Note 2)                                      | 270        | mJ    |
| dv/dt          | Peak Diode Recovery dv/dt (Note 3)   | 7.0        | V/ns  |
| $P_D$          | Total Power Dissipation(@ $T_C = 25^\circ C$ )                               | 100        | W     |
|                | Derating Factor above 25 °C  | 0.67       | W/°C  |
| $T_{STG}, T_J$ | Operating Junction Temperature & Storage Temperature                         | - 55 ~ 175 | °C    |
| $T_L$          | Maximum Lead Temperature for soldering purpose, 1/8 from Case for 5 seconds. | 300        | °C    |

### Thermal Characteristics

| Symbol          | Parameter                               | Value |      |      | Units |
|-----------------|---|-------|------|------|-------|
|                 |   | Min.  | Typ. | Max. |       |
| $R_{\theta JC}$ | Thermal Resistance, Junction-to-Case    | -     | -    | 1.50 | °C/W  |
| $R_{\theta CS}$ | Thermal Resistance, Case to Sink        | -     | 0.5  | -    | °C/W  |
| $R_{\theta JA}$ | Thermal Resistance, Junction-to-Ambient | -     | -    | 62.5 | °C/W  |

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## Electrical Characteristics (T<sub>C</sub> = 25 °C unless otherwise noted)

| Symbol                                    | Parameter                                 | Test Conditions   | Min | Typ            | Max             | Units |
|---|---|---|-----|----------------|-----------------|-------|
| <b>Off Characteristics</b>                |   |   |     |                |                 |       |
| B <sub>V</sub> DSS                        | Drain-Source Breakdown Voltage            | V <sub>GS</sub> = 0V, I <sub>D</sub> = 250uA  | 30  | -              | -               | V     |
| Δ B <sub>V</sub> DSS/<br>Δ T <sub>J</sub> | Breakdown Voltage Temperature coefficient | I <sub>D</sub> = 250uA, referenced to 25 °C   | -   | 0.02           | -               | V/°C  |
| I <sub>DSS</sub>                          | Drain-Source Leakage Current              | V <sub>DS</sub> = 30V, V <sub>GS</sub> = 0V   | -   | -              | 1               | uA    |
|   |   | V <sub>DS</sub> = 24V, T <sub>C</sub> = 150 °C  | -   | -              | 10              | uA    |
| I <sub>GSS</sub>                          | Gate-Source Leakage, Forward              | V <sub>GS</sub> = 20V, V <sub>DS</sub> = 0V   | -   | -              | 100             | nA    |
|   | Gate-Source Leakage, Reverse              | V <sub>GS</sub> = -20V, V <sub>DS</sub> = 0V  | -   | -              | -100            | nA    |
| <b>On Characteristics</b>                 |   |   |     |                |                 |       |
| V <sub>GS(th)</sub>                       | Gate Threshold Voltage                    | V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250uA                                      | 1.0 | -              | 3.0             | V     |
| R <sub>DS(ON)</sub>                       | Static Drain-Source On-state Resistance   | V <sub>GS</sub> = 10 V, I <sub>D</sub> = 30A<br>V <sub>GS</sub> = 5 V, I <sub>D</sub> = 30A     | -   | 0.011<br>0.015 | 0.0135<br>0.019 | Ω     |
| <b>Dynamic Characteristics</b>            |   |   |     |                |                 |       |
| C <sub>iss</sub>                          | Input Capacitance                         | V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 25V, f = 1MHz  | -   | 1010           | 1320            | pF    |
| C <sub>oss</sub>                          | Output Capacitance                        |   | -   | 450            | 585             |       |
| C <sub>rss</sub>                          | Reverse Transfer Capacitance              |   | -   | 130            | 170             |       |
| <b>Dynamic Characteristics</b>            |   |   |     |                |                 |       |
| t <sub>d(on)</sub>                        | Turn-on Delay Time                        | V <sub>DD</sub> = 15V, I <sub>D</sub> = 30A, R <sub>G</sub> = 50Ω<br>* see fig. 13. (Note 4, 5) | -   | 20             | 50              | ns    |
| t <sub>r</sub>                            | Rise Time                                 |   | -   | 55             | 120             |       |
| t <sub>d(off)</sub>                       | Turn-off Delay Time                       |   | -   | 53             | 116             |       |
| t <sub>f</sub>                            | Fall Time                                 |   | -   | 75             | 160             |       |
| Q <sub>g</sub>                            | Total Gate Charge                         | V <sub>DS</sub> = 24V, V <sub>GS</sub> = 5V, I <sub>D</sub> = 60A<br>* see fig. 12. (Note 4, 5) | -   | 21.5           | 28              | nC    |
| Q <sub>gs</sub>                           | Gate-Source Charge                        |   | -   | 3.6            | -               |       |
| Q <sub>gd</sub>                           | Gate-Drain Charge(Miller Charge)          |   | -   | 10.7           | -               |       |

## Source-Drain Diode Ratings and Characteristics

| Symbol          | Parameter                 | Test Conditions   | Min. | Typ. | Max. | Unit. |
|-----------------|---------------------------|---|------|------|------|-------|
| I <sub>S</sub>  | Continuous Source Current | Integral Reverse p-n Junction Diode in the MOSFET                         | -    | -    | 60   | A     |
| I <sub>SM</sub> | Pulsed Source Current     |   | -    | -    | 240  |       |
| V <sub>SD</sub> | Diode Forward Voltage     | I <sub>S</sub> = 60A, V <sub>GS</sub> = 0V                                | -    | -    | 1.5  | V     |
| t <sub>rr</sub> | Reverse Recovery Time     | I <sub>S</sub> = 60A, V <sub>GS</sub> = 0V, di <sub>F</sub> /dt = 100A/us | -    | 40   | -    | ns    |
| Q <sub>rr</sub> | Reverse Recovery Charge   |   | -    | 35   | -    | nC    |

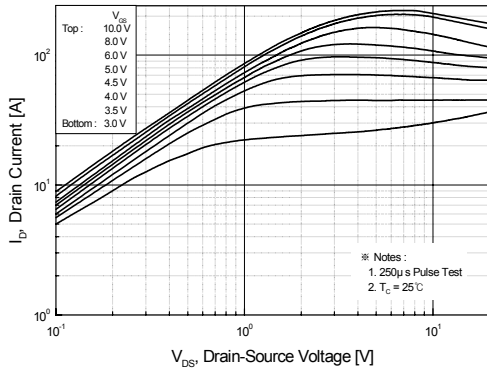
### \* NOTES

1. Repeativity rating : pulse width limited by junction temperature
2. L = 75uH, I<sub>AS</sub> = 60A, V<sub>DD</sub> = 15V, R<sub>G</sub> = 0Ω, Starting T<sub>J</sub> = 25°C
3. ISD ≤ 60A, di/dt ≤ 300A/us, V<sub>DD</sub> ≤ B<sub>V</sub>DSS, Starting T<sub>J</sub> = 25°C
4. Pulse Test : Pulse Width ≤ 300us, Duty Cycle ≤ 2%
5. Essentially independent of operating temperature.

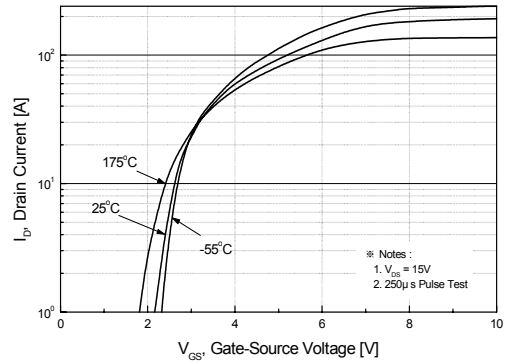


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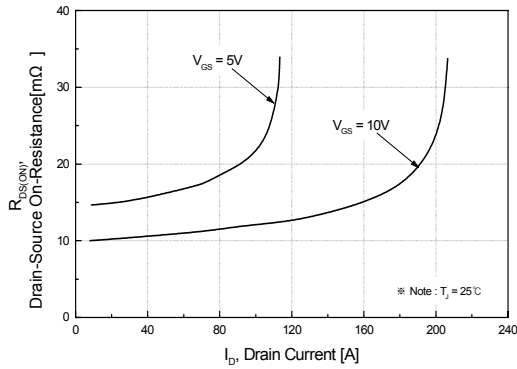
**Fig 1. On-State Characteristics**



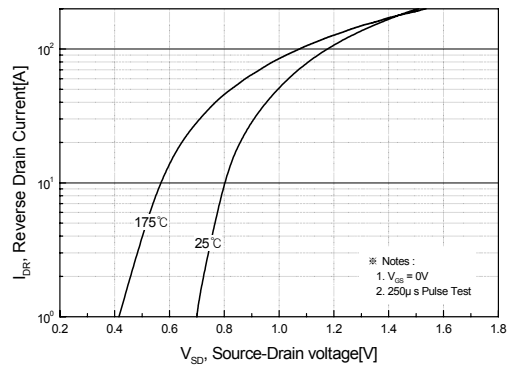
**Fig 2. Transfer Characteristics**



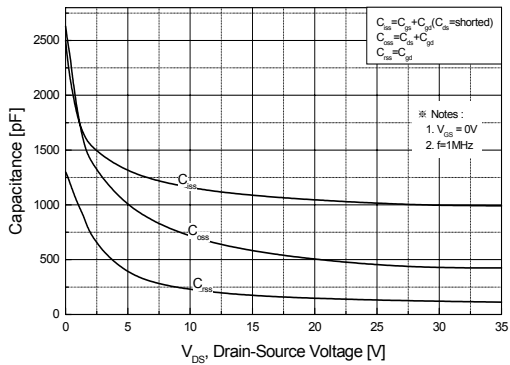
**Fig 3. On Resistance Variation vs. Drain Current and Gate Voltage**



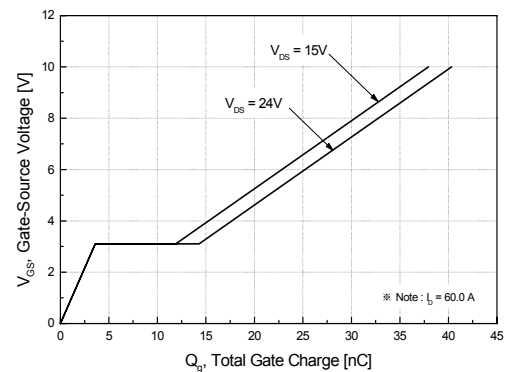
**Fig 4. On State Current vs. Allowable Case Temperature**



**Fig 5. Capacitance Characteristics (Non-Repetitive)**

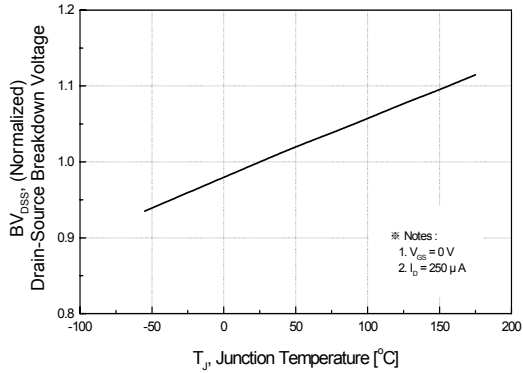


**Fig 6. Gate Charge Characteristics**

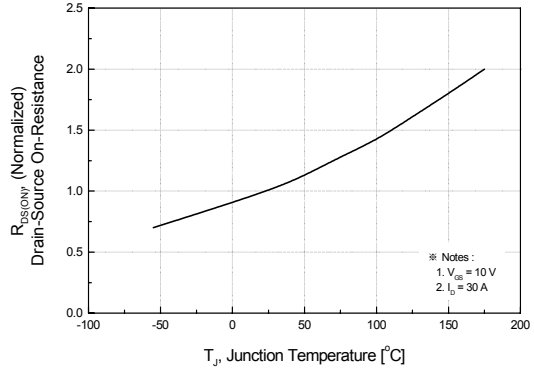


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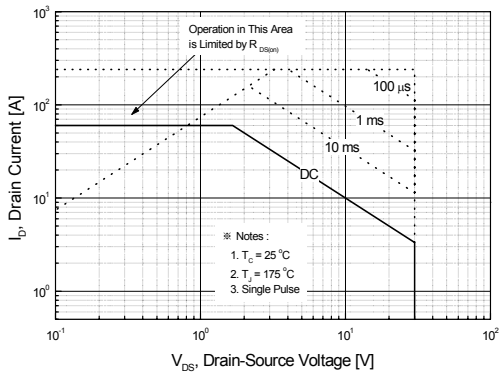
**Fig 7. Breakdown Voltage Variation vs. Junction Temperature**



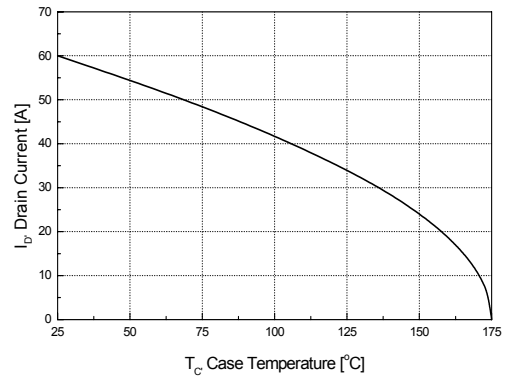
**Fig 8. On-Resistance Variation vs. Junction Temperature**



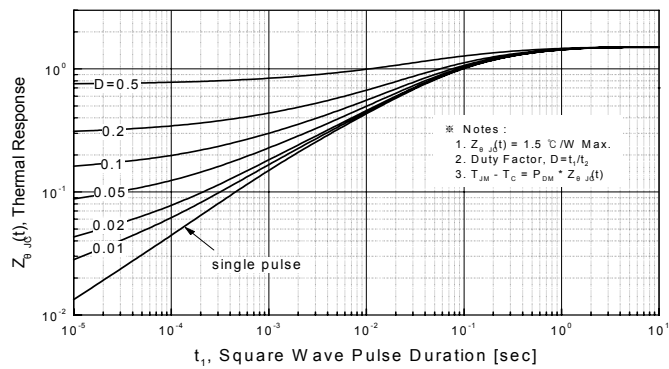
**Fig 9. Maximum Safe Operating Area**



**Fig 10. Maximum Drain Current vs. Case Temperature**



**Fig 11. Transient Thermal Response Curve**



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Fig. 12. Gate Charge Test Circuit & Waveforms

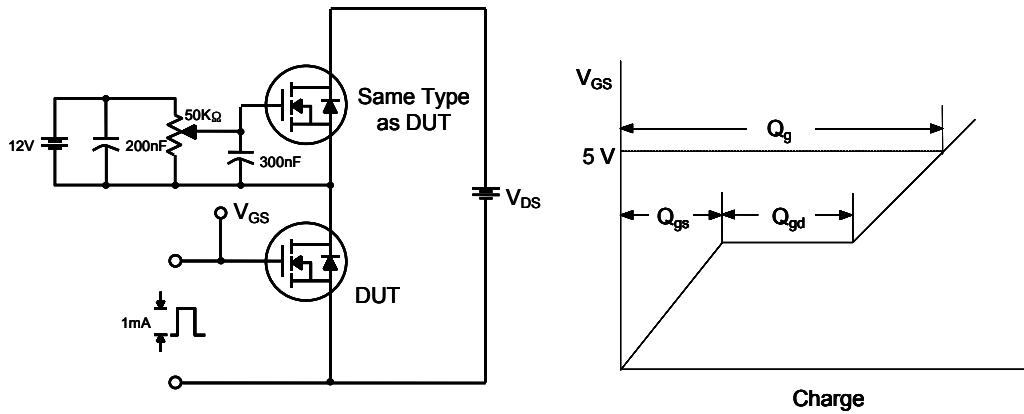


Fig. 13. Switching Time Test Circuit & Waveforms

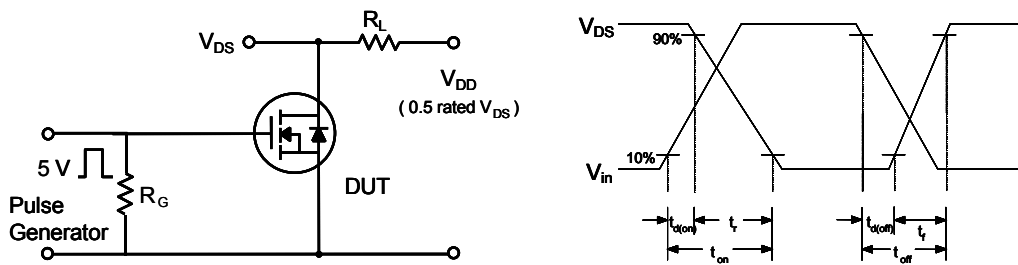
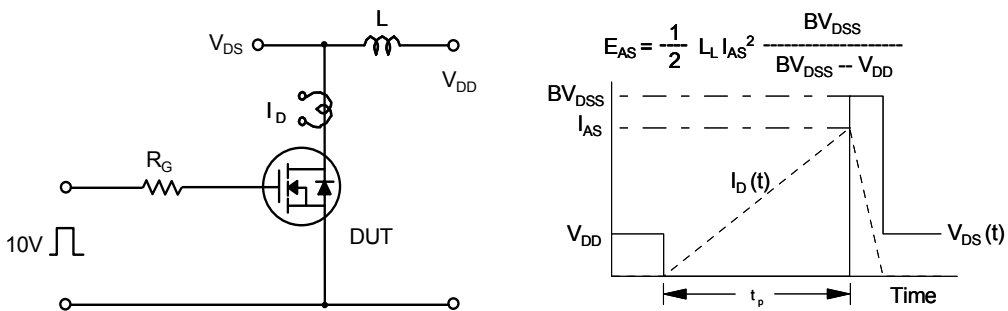
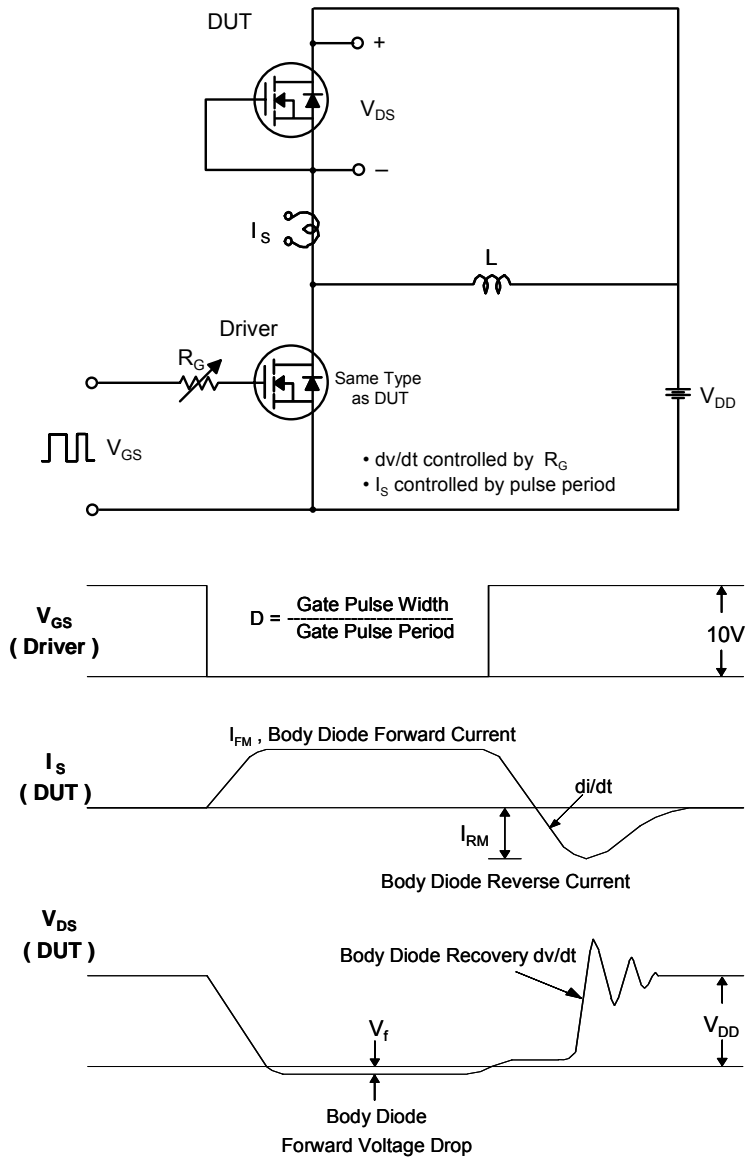


Fig. 14. Unclamped Inductive Switching Test Circuit & Waveforms



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Fig. 15. Peak Diode Recovery dv/dt Test Circuit & Waveforms



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## TO-220 Package Dimension

| Dim.          | mm   |      |      | Inch  |       |       |
|---------------|------|------|------|-------|-------|-------|
|               | Min. | Typ. | Max. | Min.  | Typ.  | Max.  |
| A             | 9.7  |      | 10.1 | 0.382 |       | 0.398 |
| B             | 6.3  |      | 6.7  | 0.248 |       | 0.264 |
| C             | 9.0  |      | 9.47 | 0.354 |       | 0.373 |
| D             | 12.8 |      | 13.3 | 0.504 |       | 0.524 |
| E             | 1.2  |      | 1.4  | 0.047 |       | 0.055 |
| F             |      | 1.7  |      |       | 0.067 |       |
| G             |      | 2.5  |      |       | 0.098 |       |
| H             | 3.0  |      | 3.4  | 0.118 |       | 0.134 |
| I             | 1.25 |      | 1.4  | 0.049 |       | 0.055 |
| J             | 2.4  |      | 2.7  | 0.094 |       | 0.106 |
| K             | 5.0  |      | 5.15 | 0.197 |       | 0.203 |
| L             | 2.2  |      | 2.6  | 0.087 |       | 0.102 |
| M             | 1.25 |      | 1.55 | 0.049 |       | 0.061 |
| N             | 0.45 |      | 0.6  | 0.018 |       | 0.024 |
| O             | 0.6  |      | 1.0  | 0.024 |       | 0.039 |
| $\varnothing$ |      | 3.6  |      |       | 0.142 |       |

